

# Approximation Algorithms for Label Cover and the Log-Density Threshold

Aravindan Vijayaraghavan

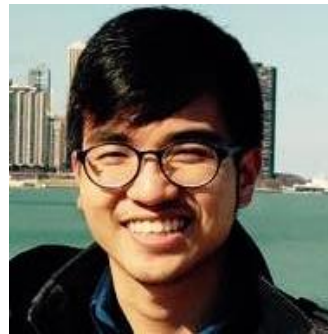
Northwestern University

Based on joint works with



Eden Chlamtac

Ben-Gurion University



Pasin Manurangsi

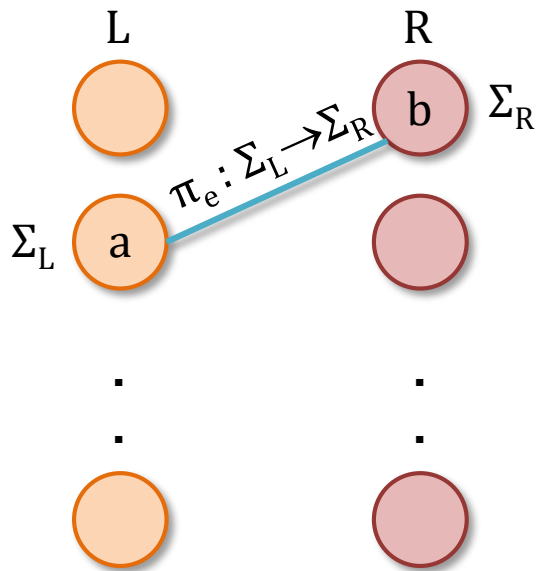
UC Berkeley



Dana Moshkovitz

UT Austin

# Label Cover



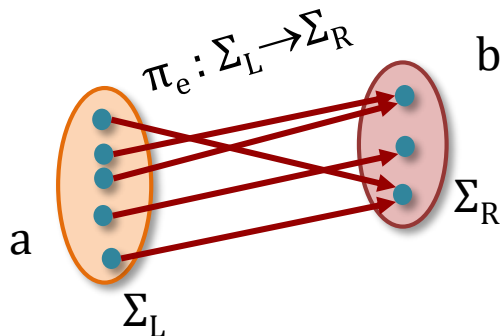
## Input

- A bipartite graph  $G = (L, R, E)$  *constraint graph*
- *Alphabet sets*  $\Sigma_L, \Sigma_R$
- *Projections*  $\pi_e: \Sigma_L \rightarrow \Sigma_R$  for each  $e \in E$

## Goal

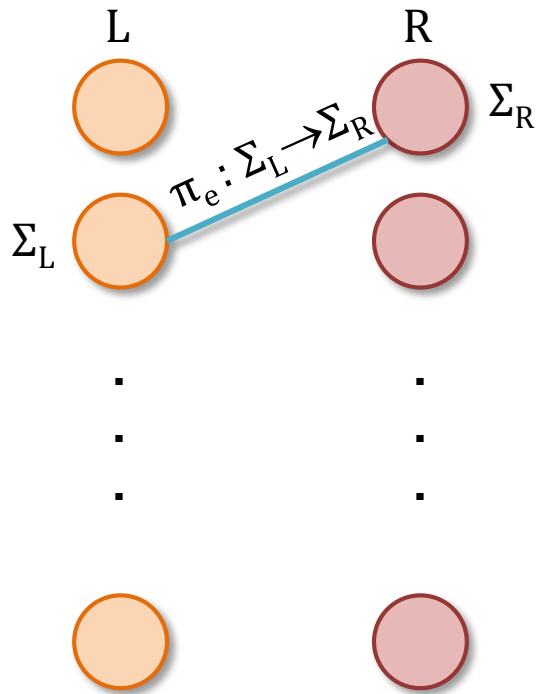
- Find *assignments*  $\phi_L: L \rightarrow \Sigma_L$  and  $\phi_R: R \rightarrow \Sigma_R$  maximizing the number of edges  $e = (a, b)$  s.t.

$$\pi_e(\phi_L(a)) = \phi_R(b).$$



- *Value* – fraction of edges satisfied.

# Some Notation



- $n$  = number of vertices in the graph, i.e.,  $n = |L| + |R|$
- $k$  = the size of left alphabet set, i.e.,  $k = |\Sigma_L| \geq |\Sigma_R|$
- $N$  = the size of instance, i.e.,  $N = nk$
- $\delta$  = the approximation ratio

# Why is Label Cover Important?

## **PCP Theorem** ([AS98][ALMSS98]...)

Given a Label Cover instance, it is NP-Hard to distinguish between the following two cases:

- The instance is satisfiable, i.e., its value is 1.
- Its value is at most  $\delta$ .

**Max-3SAT** is NP-Hard to approximate.  
[Hastad97]  
[BGS95]

**Set Cover** is NP-Hard to approximate.  
[Lund-Yannakakis94]  
...  
[Feige98]  
[Moshkovitz12]  
[Moshkovitz-Raz08]+  
[Dinur-Steurer13]

**Closest Vector Problem** is NP-Hard to approximate.  
[Khot10]

**Directed Sparsest Cut** is NP-Hard to approximate.  
[Chuzhoy-Khanna09]

...

# Label Cover: what do we know?

Approximation factor  $\delta$  : given a satisfiable instance of Label Cover,  
how many constraints does the algorithm satisfy?

## Hardness Results

(Note:  $N = nk$ )

[Arora-Safra98, ALMSS98]

NP-hard

Some constant  $0 < \delta < 1$

[Raz98]

NP-hard

Every constant  $0 < \delta$

[Moshkovitz-Raz08]

NP-hard

$\delta = 1/\log^c N$  for some  $c > 0$

[Dinur-Steurer13]

NP-hard

$\delta = 1/\log^c N$  for every  $c > 0$

[Dinur07] + [Raz98]

ETH-hard

$\delta = 1/N^{1/\text{poly log log log } N}$

**Projection Games Conjecture**

NP-hard

$\delta = 1/N^c$  for some  $c > 0$

[BGLR93, Moskovitz15]

## Approximation Algorithms

Folklore

$\delta \geq 1/n, 1/k$

[Peleg02]

$\delta \geq 1/N^{1/2}$

[Charikar-Hajiaghayi-Karloff09]

$\delta \geq 1/N^{1/3}$

[M-Moshkovitz13]

$\delta \geq 1/N^{1/4}$

Q: What's the right  $c$ ?

# Better Inapproximability from LC?

## **PCP Theorem** ([AS98][ALMSS98]...)

Given a Label Cover instance, it is NP-Hard to distinguish between the following two cases:

- The instance is satisfiable, i.e., its value is **1**.
- Its value is at most  $\delta$ .

$$\delta = 1/N^c$$

**Max-3SAT** is NP-Hard to approximate.  
[Hastad97]  
[BGS95]

**Set Cover** is NP-Hard to approximate.  
[Lund-Yannakakis94]  
...  
[Feige98]  
[Moshkovitz12]  
[Moshkovitz-Raz08]+  
[Dinur-Steurer13]

**Closest Vector Problem** is NP-Hard to approximate.  
[Khot10]

**Directed Sparsest Cut** is NP-Hard to approximate.  
[Chuzhoy-Khanna09]

...

$$\delta = 1/N^{c'}$$

# This Work

Conjecture  $\mathbf{c} = 3 - 2\sqrt{2} \approx 0.1716$  (approximability threshold  $N^{-\mathbf{c}}$ ), using the Log-density method

## Results:

- A matching  $N^{-(3-2\sqrt{2})}$ -approximation algorithm for semi-random case where the constraint graph is random.
- An improved  $N^{-0.2325}$ -approximation algorithm for worst case instances.
- A  $N^{-1/8 + o(\epsilon)}$  integrality gap for  $N^\epsilon$ -level Lasserre SDP (aka Sum-of-Square) relaxation of Label Cover.

# Log-Density Method

- Introduced while studying Densest k-subgraph by Bhaskara-Charikar-Chlamtac-Feige-**V** [2010]
- Study how “simple local” algorithms perform on **average-case instances**
- Use the insight to come up with an algorithm and/or lower bounds for more general (worst-case) instances
- Results in state-of-the-art algorithms (and some lower bounds) for Densest-k-Subgraph[BCCFV'10], Degree-bounded Spanners[CDK'12], Small-Set Vertex Expansion [CDM'17]...



# Log-Density Method: Outline

## **Random vs Planted**

Consider a distinguishing problem between a “random” instance and one with a “planted” solution

---

# Log-Density Method: Outline

<b>Random vs Planted</b>	Consider a distinguishing problem between a “random” instance and one with a “planted” solution
<b>Counting Witnesses</b>	Restrict ourselves to algorithms that only count a certain kind of “witnesses”



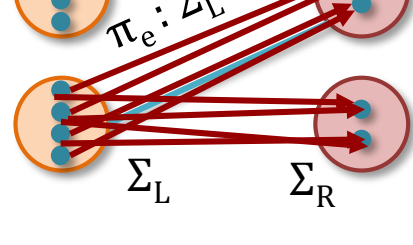
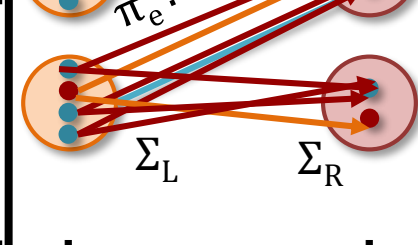
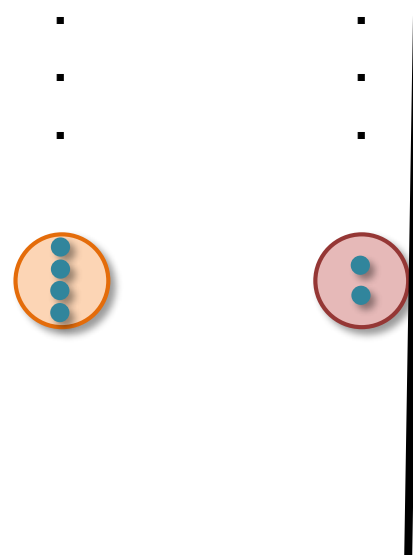
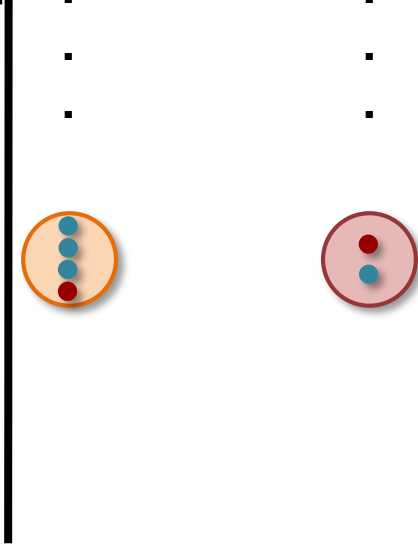
# Log-Density Method: Outline

<b>Random vs Planted</b>	Consider a distinguishing problem between a “random” instance and one with a “planted” solution
<b>Counting Witnesses</b>	Restrict ourselves to algorithms that only count a certain kind of “witnesses”
<b>Log Density Threshold</b>	Compute the threshold at which witness counting algorithms stop/start working

# Log-Density Method: Outline

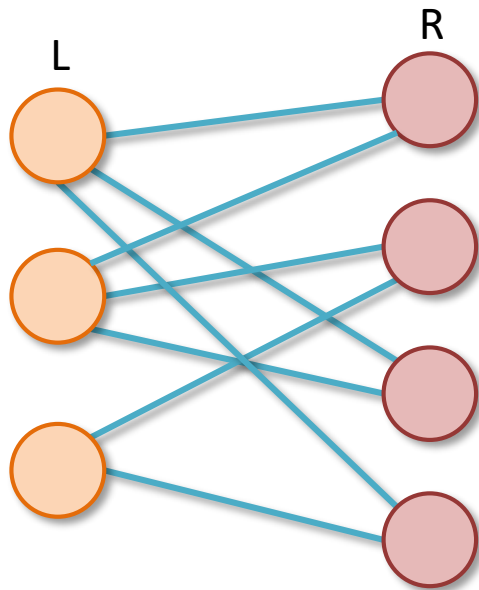
<b>Random vs Planted</b>	Consider a distinguishing problem between a “random” instance and one with a “planted” solution
<b>Counting Witnesses</b>	Restrict ourselves to algorithms that only count a certain kind of “witnesses”
<b>Log Density Threshold</b>	Compute the threshold at which witness counting algorithms stop/start working
<b>Algorithm</b>	Use the ideas from previous steps to come up with an algorithm

# Distinguish Random vs Planted

	Random	Planted	
	Constraint graph $\mathbf{G} = (\mathbf{L}, \mathbf{R}, \mathbf{E})$ is an Erdős-Rényi random bipartite graph $\mathbf{G}(n/2, n/2, p = \Delta/n)$ .		
	Each $\pi_e$ is a random d-to-1 function	Fix a solution $\varphi_L^*, \varphi_R^*$  Each $\pi_{(a,b)}$ is a random d-to-1 function s.t. $\pi_{(a,b)}(\varphi_L^*(a)) = \varphi_R^*(b)$	

# Witness-Based Algorithm

**Witness:** a constant-size graph  $W$

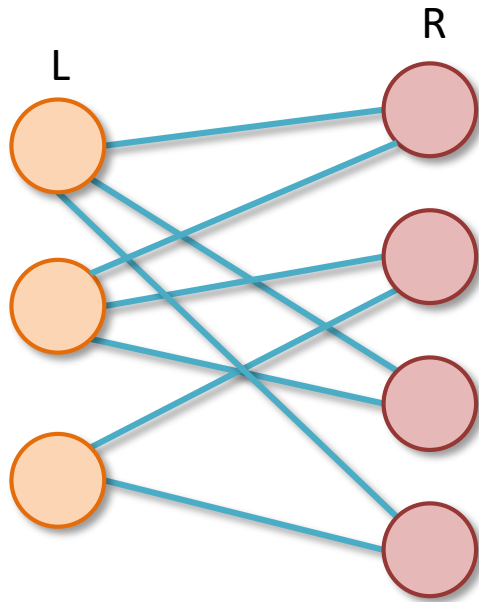


## Distinguishing Algorithm

- Find each occurrence  $H$  of  $W$  in the constraint graph  $G(L,R,E)$ 
  - Check whether there is a satisfying assignment of  $H$
- If there are satisfying assignments for each  $H$ , output “**PLANTED**”.
- Otherwise, output “**RANDOM**”.

# The Log-density Threshold

**Witness:** a constant-size graph **W**



**When does the algorithm work?**

1. **W** must appear (w.h.p.) in the constraint graph **G = (L, R, E)**
2. There must be no satisfying assignment for **W** (w.h.p.) for **RANDOM** instances (random projections)

# The Log-density Threshold

Witness exists exactly when:

*Log-density* of  
the **projection**

$$\underbrace{2 \log_n \Delta}_{\text{Log-density of the constraint graph}} > \underbrace{\log_k d}_{\text{Log-density of the projection}}$$

*Log-density* of the  
**constraint graph**

$\Delta$ : degree,  $n$ : # of vertices

$k$ : alphabet size,  $d$ : # of preimages

**When does the algorithm work?**

1. **W** must appear (w.h.p.) in the constraint graph  $\mathbf{G} = (\mathbf{L}, \mathbf{R}, \mathbf{E})$
2. There must be no satisfying assignment for **W** (w.h.p.) for random instances



# Towards an Approximation Algorithm

## Random Planted Model

**Step 1:** Constraint graph  $\mathbf{G} = (\mathbf{L}, \mathbf{R}, \mathbf{E})$  is random.

An Erdős-Rényi random bipartite graph  $\mathbf{G}(n/2, n/2, p = \Delta/n)$ .

**Step 2:** Fix a planted solution/ assignment  $\varphi_L, \varphi_R$ .

Each projection  $\pi_{(a,b)}$  is a random d-to-1 function s.t.

$$\pi_{(a,b)}(\varphi_L(a)) = \varphi_R(b)$$

**Goal:** Find an assignment that satisfies as many edges as possible

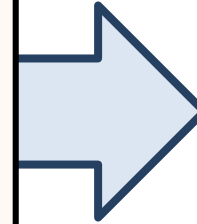
Note: easier than semi-random model

# Algorithm for Planted Model

Case 1 (Lower Log-density of G):  $2 \log_n \Delta \leq \log_k d$

Pick the best of the following:

- $d/k$ -approx: pick a random assignment
- $1/\Delta$ -approx: satisfy a spanning tree

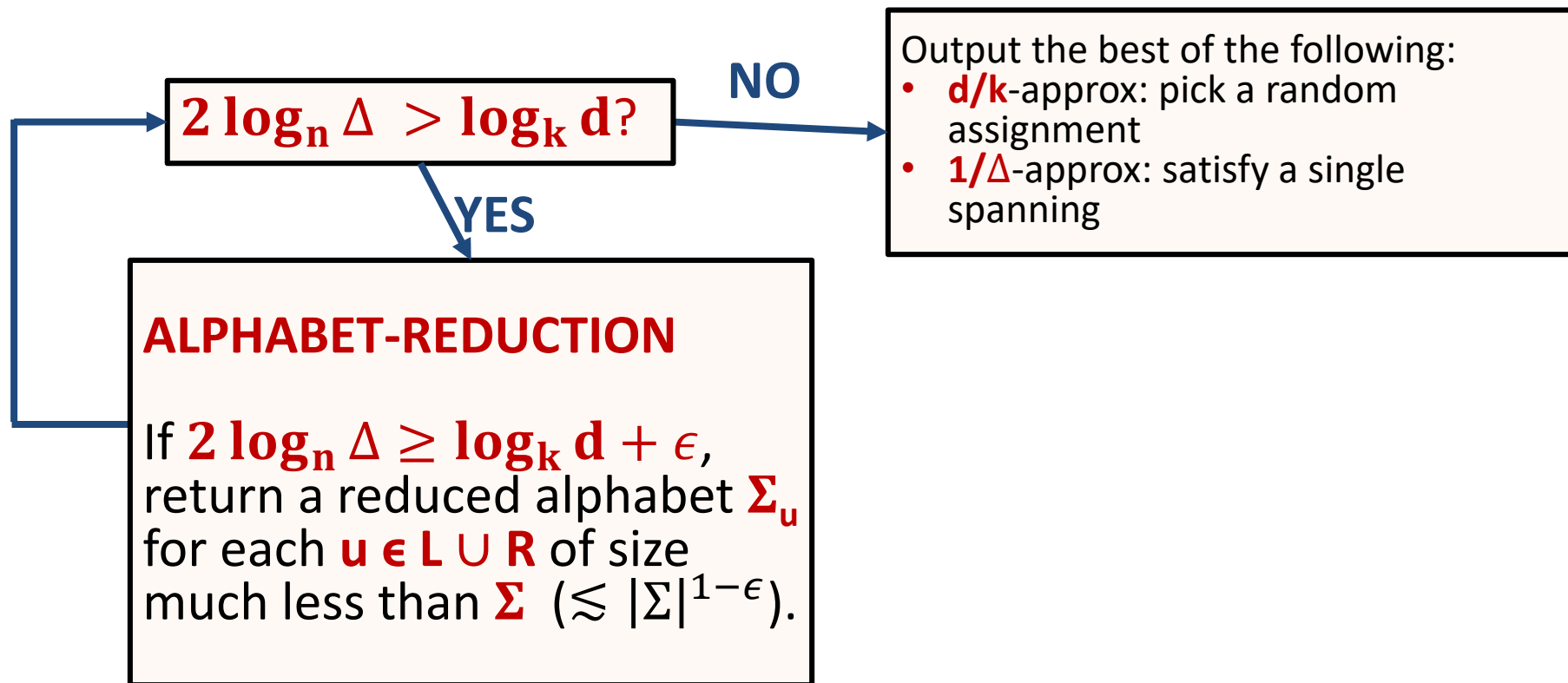


$N^{-(3-2\sqrt{2})}$ -  
approximation  
algorithm

- Hard for local witnesses. Output something trivial.
- Better approx. guarantee would solve distinguishing problem in this regime as value of a random instance is at most  $O(\max\{d/k, 1/\Delta\})$

# Algorithm for Planted Model

Case 2 (Higher Log-density of G):  $2 \log_n \Delta > \log_k d$



# Alphabet Reduction Algorithm

Algorithm works in multiple steps and maintains

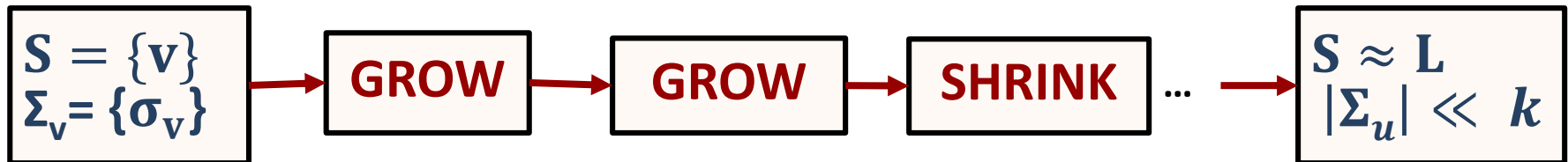
- a candidate set  $S$ , and
- a candidate set of labels  $\Sigma_u$  for each vertex  $u \in S$

First step:

Enumerate all possible choices of a left vertex  $v$  and a label  $\sigma_v$

**GROW**  
 $S$  larger  
 $\Sigma_u$  larger

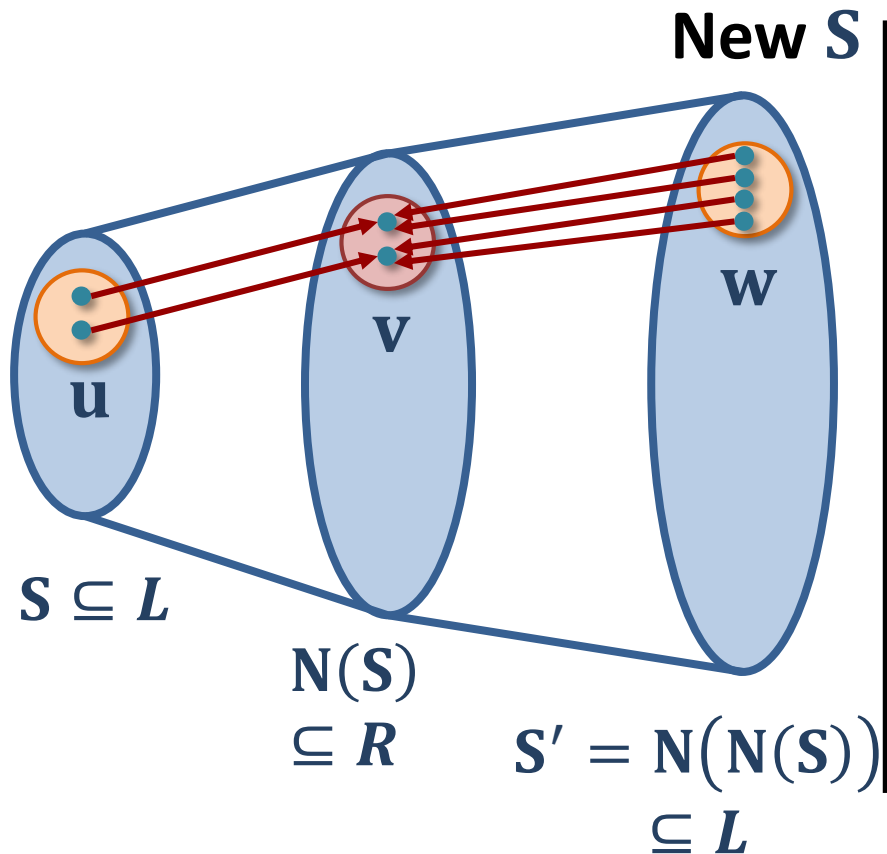
**SHRINK**  
 $S$  smaller  
 $\Sigma_u$  smaller



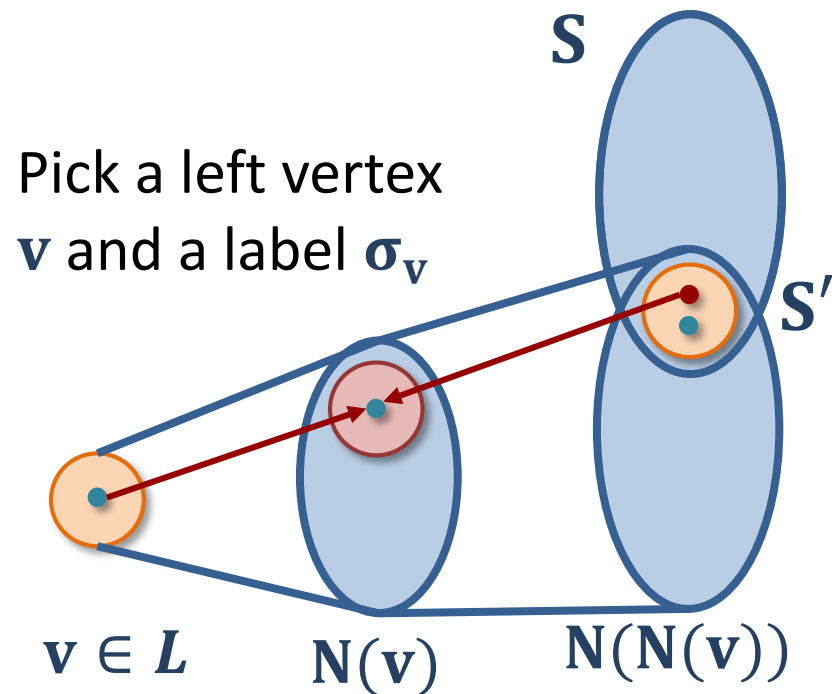
The sequence of Growth and Shrink steps given by the local witness

# Alphabet Reduction Algorithm

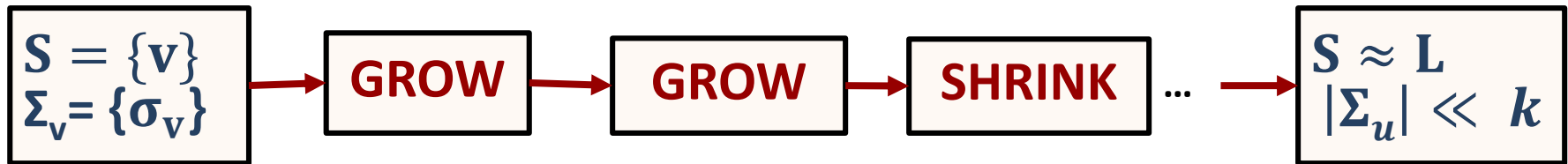
**GROW**



**SHRINK**



# Algorithm for Planted Model



**ALPHABET-REDUCTION:** If  $2 \log_n \Delta \geq \log_k d + \epsilon$ , we can find in polynomial time, an instance on  $G(V, E)$  with alphabets  $\Sigma'_L, \Sigma'_R$  that is satisfiable and has  $|\Sigma'_L| \lesssim |\Sigma_L|^{1-\epsilon}$ .

Implies a  $N^{-(3-2\sqrt{2})}$ -approximation algorithm for planted random instances.

# Semi-random Models

## Semi-Random Model 1 (easy)

**Step 1:** Constraint graph  $\mathbf{G} = (\mathbf{L}, \mathbf{R}, \mathbf{E})$  is ~~random~~ *arbitrary*

An Erdős-Rényi random bipartite graph  $\mathbf{G}(n/2, n/2, p = \Delta/n)$ .

**Step 2:** Fix  $\varphi_L, \varphi_R$ . Each projection  $\pi_{(a,b)}$  is a *random* d-to-1 function s.t.  $\pi_{(a,b)}(\varphi_L(a)) = \varphi_R(b)$

## Semi-Random Model 2 (more challenging)

**Step 1:** Constraint graph  $\mathbf{G} = (\mathbf{L}, \mathbf{R}, \mathbf{E})$  is *random*

An Erdős-Rényi random bipartite graph  $\mathbf{G}(n/2, n/2, p = \Delta/n)$ .

**Step 2:** Fix  $\varphi_L, \varphi_R$ . Each projection  $\pi_{(a,b)}$  is a ~~random~~ *arbitrary* d-to-1 function s.t.  $\pi_{(a,b)}(\varphi_L(a)) = \varphi_R(b)$

# Semi-random models

## Semi-Random model 2:

**Step 1:** Constraint graph  $G = (L, R, E)$  is **random**

An Erdős-Rényi random bipartite graph  $G(n/2, n/2, p = \Delta/n)$ .

**Step 2:** Fix  $\varphi_L, \varphi_R$ . Each projection  $\pi_{(a,b)}$  is a ~~random~~ **arbitrary** d-to-1 function s.t.  $\pi_{(a,b)}(\varphi_L(a)) = \varphi_R(b)$

- The projections are not **d-to-1 or random**

**Solution:** Bucketing, and ensuring approximate regularity

**Problem:** The alphabet reduction algorithm may not reduce size of compatible alphabet; **SHRINK** fails!

**Main Idea:** If **SHRINK** fails, we can find a good assignment to the whole instance (need “robust” vertex expansion of instance)



# Worst-Case Instances

**Step 1:** Constraint graph  $\mathbf{G} = (\mathbf{L}, \mathbf{R}, \mathbf{E})$  is ~~random~~ *arbitrary*  
An Erdős-Rényi random bipartite graph  $\mathbf{G}(n/2, n/2, p = \Delta/n)$ .

**Step 2:** Fix  $\varphi_L, \varphi_R$ . Each projection  $\pi_{(a,b)}$  is a ~~random~~ *arbitrary*  
d-to-1 function s.t.  $\pi_{(a,b)}(\varphi_L(a)) = \varphi_R(b)$

**Problem:** The constraint graph may not be expanding. **GROW** fails!

**Partial Solution:** Partitioning the instance into subinstances

# Takeaways

- Via **log-density method**, identify a barrier for algorithms, and conjecture a threshold at which Label Cover becomes hard.
- An algorithm for **semi-random** case that matches threshold
- An improved (but **not matching**) algorithm for **worst** case
- A polynomial (**not matching**) **Sum-of-Squares** lower bound
- Similar results for Max-CSPs with approximability threshold at  $N^{-1/4}$

*Log-density* of the **projection**

$$\underbrace{2 \log_n \Delta}_{\text{Log-density of the constraint graph}} > \underbrace{\log_k d}_{\text{Log-density of the projection}}$$

*Log-density* of the **constraint graph**

$\Delta$ : degree,  $n$ : # of vertices

$k$ : alphabet size,  $d$ : # of preimages

# Open Questions

Conjecture  $c = 3 - 2\sqrt{2} \approx 0.1716$  (approximability threshold  $N^{-c}$ ), using the Log-density method

- A **matching** algorithm for **worst** case?
- Is our conjectured threshold correct even in average-case?
- Evidence for hardness using **Sum-of-Squares** lower bounds?
- A useful average-case hardness assumption?

Thank you!

Questions?